Search Notes

Application/Control No.					
10/777 155					

Applicant(s)/Patent under Reexamination

LAMPELL ET AL.

Art Unit

Examiner

Quynh H. Nguyen

2614

SEARCHED					
Class	Subclass	Date	Examiner		
379	189 114.02 190 196 197	8/3/2006	QN		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
searched:East, USPAT, USPGPub	8/3/2006	QN		
inventor searched through PALM database	8/3/2006	QN		